Searcn Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/666,280	YOON ET AL.	
Examiner	Art Unit	
Oanh Duong	2155	

SEARCHED				
Class	Subclass	Date	Examiner	
709	203, 217, 219 226, 229	9/5/2006	O.D	
707	3, 5, 10	9/5/2006	O.D	
707	104.1	9/5/2006	O.D	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH		) _
	DATE	EXMR
EAST text search of USPAT, JPO, EPO, DERWENT, IMB_TDB, US- PGPUB	9/5/2006	O.D